

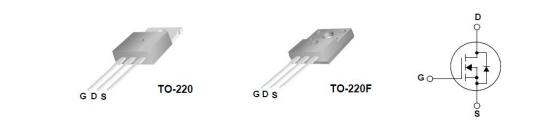
SLP10N60S/ SLF10N60S 600V N-Channel MOSFET

General Description

This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 10A, 600V, $R_{DS(on) typ}$ =0.75 Ω @V_{GS} = 10 V
- Low gate charge (typical 28.3nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_c = 25°C unless otherwise noted

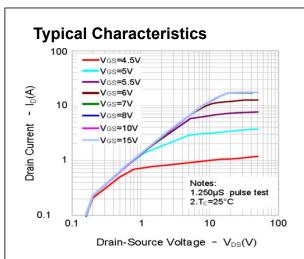
Symbol	Parameter		SLP10N60S	SLF10N60S	Units
V _{DSS}	Drain-Source Voltage		600		V
	Drain Current - Continuous (T _c = 25°C)		10		А
Ι _D	- Continuous (T _c = 100°C)		6.3		А
I _{DM}	Drain Current - Pulsed (Not	e 1)	4	А	
V _{GSS}	Gate-Source Voltage		±30		V
EAS	Single Pulsed Avalanche Energy (No	ie 2)	65	mJ	
I _{AR}	Avalanche Current (Not	e 1)	1	Α	
P_D	Power Dissipation ($T_c = 25^{\circ}C$)		150	50	W
	- Derate above 25°C		1.2	0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
	Maximum lead temperature for soldering purposes,				
T∟	1/8" from case for 5 seconds		300		°C

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLP10N60S	SLF10N60S	Units
R _{eJC}	Thermal Resistance, Junction-to-Case	0.8	2.5	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

stics burce Breakdown Voltage wn Voltage Temperature ent te Voltage Drain Current dy Leakage Current, Forward dy Leakage Current, Reverse stics reshold Voltage ain-Source stance	$V_{GS} = 0 V, I_D = 250 uA$ $I_D = 250 uA, Referenced$ $V_{DS} = 600 V, V_{GS} = 0 V$ $V_{DS} = 480 V, T_C = 125^{\circ}C$ $V_{GS} = 30 V, V_{DS} = 0 V$ $V_{GS} = -30 V, V_{DS} = 0 V$ $V_{DS} = V_{GS}, I_D = 250 uA$		600 	 0.88 	 1 10 100	V V/°C uA uA
wn Voltage Temperature ent te Voltage Drain Current dy Leakage Current, Forward dy Leakage Current, Reverse stics reshold Voltage rain-Source	$I_{D} = 250 \text{ uA}, \text{ Referenced}$ $V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = 480 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$ $V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ $V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			0.88 	 1 10 100	V/°C uA uA
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reshold Voltage ain-Source	V _{DS} = V _{GS} , I _D = 250 uA			1	-100	nA
ain-Source	$V_{DS} = V_{GS}, I_D = 250 \text{ uA}$			•		
ain-Source	20 00, 2		2.0		4.0	V
	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5 \text{ A}$			0.75	0.9	Ω
Transconductance	$V_{DS} = 40 V, I_D = 5 A$ (Note 4)		9		S
acteristics	•	I				
pacitance				1086		pF
Capacitance			143		pF	
Transfer Capacitance	- 1 - 1.0 MHZ			12.0		pF
racteristics	l	I				
Delay Time				21.7		ns
Rise Time	$V_{DD} = 300V, I_D = 10 A,$			41.8		ns
Delay Time		Note 4, 5)		79.4		ns
Fall Time		,,.,,		40.9	-	ns
te Charge	$V_{DS} = 480 \text{ V}, I_D = 10 \text{ A},$			28.3		nC
urce Charge	V _{GS} = 10 V	_		6.26		nC
	(Note 4, 5)	Note 4, 5)		13.2		nC
ain Charge		L				
ain Charge Diode Characteristics a		ļs				
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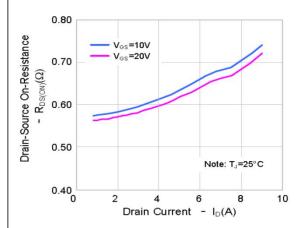
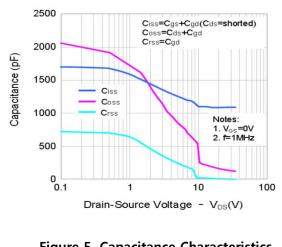


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage





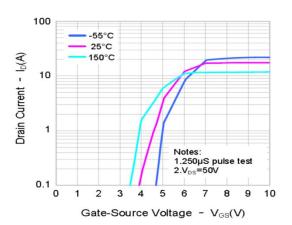


Figure 2. Transfer Characteristics

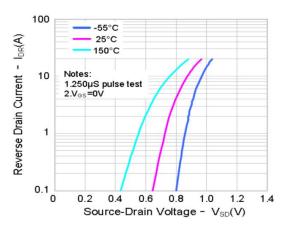
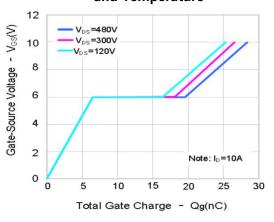
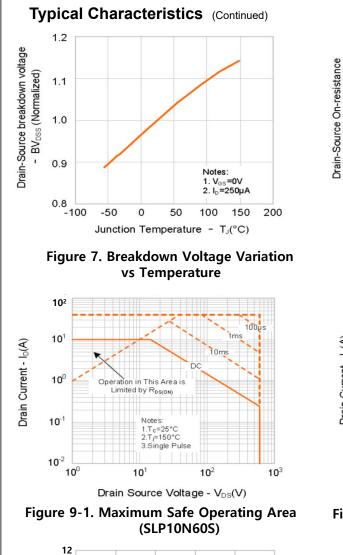


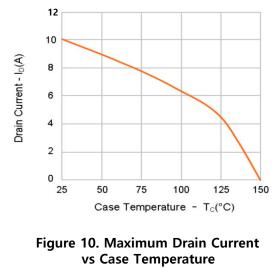
Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature





SLP10N60S/SLF10N60S





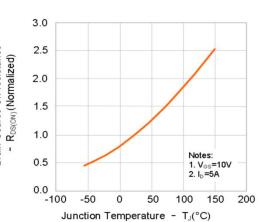


Figure 8. On-Resistance Variation vs Temperature

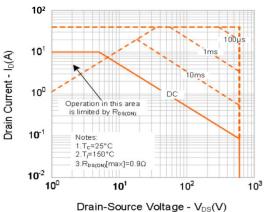


Figure 9-2. Maximum Safe Operating Area (SLF10N60S)

